Coatings

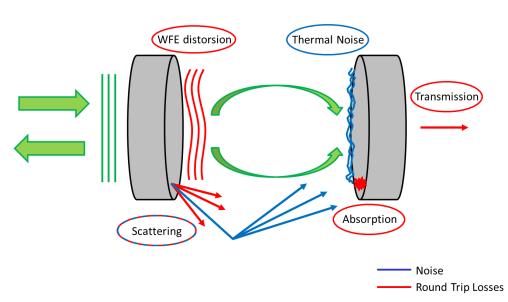
ET-France meeting 2025

Benoit Sassolas





Major effects in mirror coating



Advanced Virgo: DOI 10.1088/0264-9381/32/2/024001

ET Design Report 2020: https://apps.et-gw.eu/tds/ql/?c=15418

Parameters	Adv Virgo	ET-HF	ET-LF
Arm power	100 - 150 kW (O4)	3 MW	18 kW
Mirror mass	42 kg	200 kg	211 kg
Temperature	290 K	290 K	10-20 K
Laser Wavelength	1064 nm	1064 nm	1550 nm
Mirror diameter	35 cm	62 cm	45 cm
Beam radius	5 - 6 cm	12 cm	9 cm
Bulk absorption	Suprasil < 0.5 3002 ppm/cm 0.2 ppm/cm (3002)		20 ppm/cm
Coating absorption	0.3-0.4 ppm	0.3-0.4 ppm <0.5ppm	
Scattering	<10 ppm <10 pp		<10 ppm

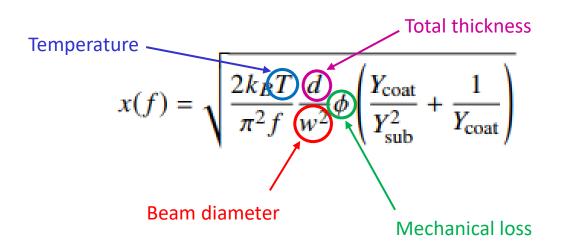






Thermal Noise: the most critical issue ...

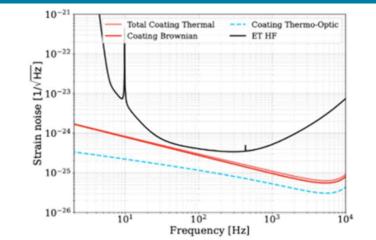
Amplitude Spectral Density of thermal noise

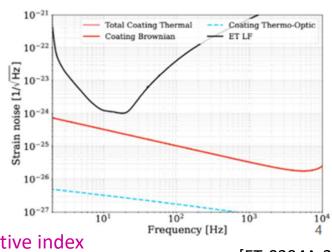




- Reducing the temperature (ET-LF) => cryogenic
- Reducing the total thickness => increase the contrast in refractive index
- Increasing the beam diameter (ET-LF & ET-HF) => larger mirrors
- Reducing the loss of the coating materials
 - o Factor of 3.8 for ET-LF Challenging requirements !!!

o Factor of 2.6 for ET-HF | A coating compliant with the A+ specs would be suitable for ET-HF!!!









... but do not forget that other parameters matter !

The coating MUST be:

- Uniform over a large area (~ Ø 200mm)
- Defect-free (neither point scatterers nor point absorber)
- Low scattering
- Non-birefringent

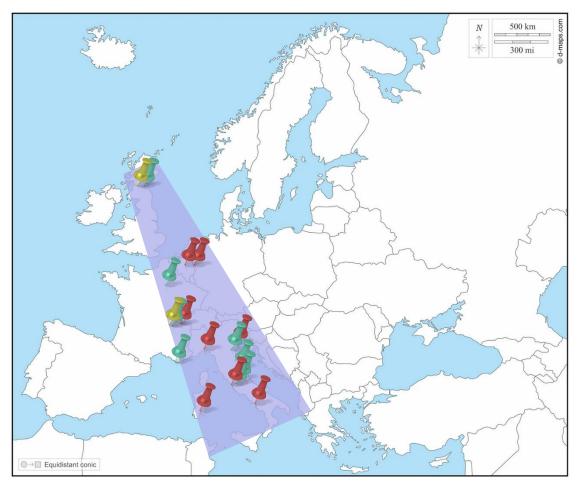
All the parameters are interconnected and have a strong impact on the optimization of deposition process.

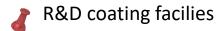
The final decision can be made only on a real HR stack that complies with all the specs. A scale 1:1 pathfinder?





The european « coating corridor »





Characterization facilies (mechanical loss, absorption, birefringence, ellipsometry, structural)

Large coating chambers

No real coordinated R&D activities at the project level.

R&D roadmap in preparation

Pros: identify lack of research on

certain aspects.

Cons: only consultative right now



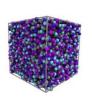




Several solutions under investigation

Amorphous coatings

- SiN_x
- Ti:GeO₂
- a-Si
- Fluorides
- SiO₂:HfO₂
- TiO₂:SiO₂
- Al₂O₃
- Multimaterial structure
- Nanolayering
- Implantation





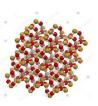






Crystalline coatings

- GaAs/AlGaAs
- Cr_2O_3/Fe_2O_3
- Hybrid crystalline/amorphous







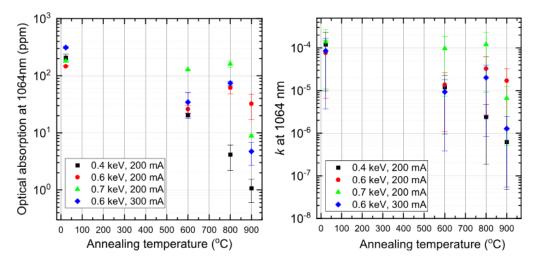




Amorphous

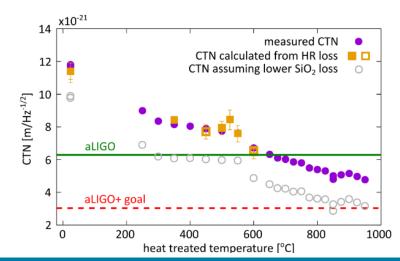
Si₃N₄ [Wallace et al. Class. Quantum Grav. 41 (2024) 095005]

- k~7e-7 ultra low absorbing nitride
- φ~3e-4



Ti:SiO₂ [McGhee PRL 131, 171401 (2023)]

- HR CTN ~75% aLIGO
- A~1 ppm



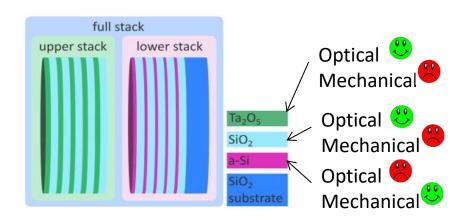






Multimaterial

Material	CTN (wrt aLIGO)	Absorption (ppm)	Ref.	Comment
SiO ₂ /SiO _x /Ta ₂ O ₅	0.97	1	Demos et al. Class. Quantum Grav. 42 115012 2025	T<<5ppm
SiO ₂ /Ti:Ta ₂ O ₅ /SiN _x	0.82	1.5	VIR-0888A-25	
SiO ₂ /Ti:Ta ₂ O ₅ /TiGeO ₂	0.81	0.7	VIR-0888A-25	





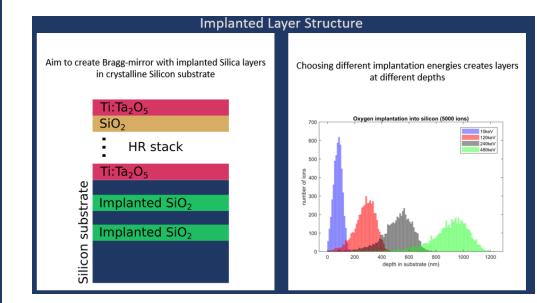


Implantation

Implanting O and N Ions into crystalline Silicon might enable creating Bragg mirror layers with good mechanical loss and absorption

Crystalline Silicon substrates will be used in the Einstein Telescope at cryogenic temperatures

Just bought an ion implanter (located in California)

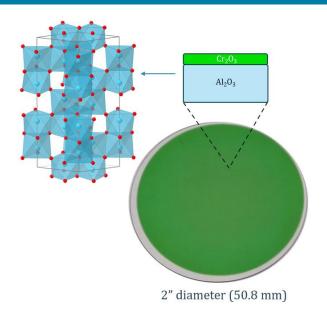


LIGO-G2400579-x0





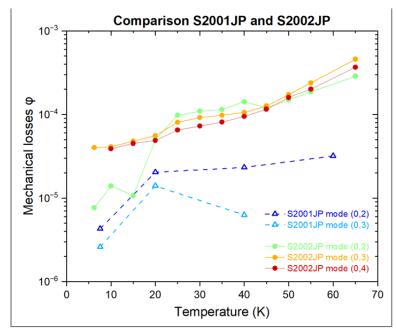
Oxide crystaline coatings



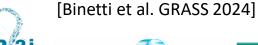
Cr₂O₃ can be directly grown onto sapphire. Demonstation of a 500 nm thick on a \emptyset 2" substrate.

Strong impact of the growth quality on the mechanical loss.

Good epitaxy quality allows to achieve ϕ =3e-6 at cryogenic temperature.



Comparison film with good epitaxy (S2001JP) and film with mixed polycrystalline/epitaxial structure (S2002JP)







GaAs/AlGaAs

Several project aim to develop compliant coating over Ø200mm

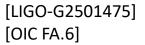
- MICRONG R. Flaminio
- MIRI S. Penn



GaAs/InGaAs coating on \varnothing 20 cm (max GaAs wafer available).

Birefringence variation of 5% over \emptyset 100 mm.

New plan growth on ∅30cm Ge wafer.









World's First MBE Growth of GaAs on 30-cm Ge Wafers done in May

- The test showed that uniform growth over the full diameter was achieved.
- · The test was only on the GaAs base layer.
- GaAs was not single polarization due to offcut manufacturing error by Umicore.
- Full growth and bonding tests will occur once offcut error resolved.

Conclusion

A lot of activities are ongoing regarding the fabrication of the ET coating.

Quality and performance have been improved.

Still a lot of work that <u>all</u> the requirements can be met.

Scaling up to be checked/developped.

To be continued ...



